

<b>Notice of References Cited</b>	Application/Control No. 10/759,457	Applicant(s)/Patent Under Reexamination HONG, KWON	
	Examiner Toniae M. Thomas	Art Unit 2822	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0016036 A1	02-2002	Hong et al.	438/243
	B	US-2004/0041194 A1	03-2004	Marsh, Eugene P.	257/306
	C	US-2003/0042609 A1	03-2003	Choi, Hyung-Bok	257/758
	D	US-2002/0074661 A1	06-2002	Tsunemine et al.	257/758
	E	US-2004/0135182 A1	07-2004	An et al.	257/295
	F	US-5,879,957	03-1999	Joo, Jae Hyun	438/3
	G	US-6,384,443 B1	05-2002	Tsunemine, Yoshikazu	257/303
	H	US-6,451,666 B2	09-2002	Hong et al.	438/397
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	KR2001113317A ✓	12-2001	KR	Shin, H. S.	
	O	KR2002002633A ✓	01-2002	KR	Kwon, O. S.	
	P	KR2002037804A ✓	05-2002	KR	Choi et al.	
	Q	KR2002045261A ✓	06-2002	KR	Shin, H. S.	
	R	KR2003002048A ✓	01-2003	KR	Choi et al.	
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.